

Notice of References Cited	Application/Control No. 10/726,666	Applicant(s)/Patent Under Reexamination YOSHIOKA ET AL.	
	Examiner Tae H. Yoon	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,225,238	05-2001	Wu, Hui-Jung	438/778
*	C	US-2002/0059899 A1	05-2002	Seta et al.	117/97
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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